

TOLL Plastic-Encapsulate MOSFETS

● Features

- $V_{DS}=85V$
- $I_D=160A$
- $R_{DS(on)}@V_{GS}=10V < 4.6m\Omega$
- Low Gate Charge and $R_{DS(on)}$
- Fast Switching Speed
- Advanced Split Gate Trench Technology

Drain-source Voltage

85 V

Drain Current

160 Ampere

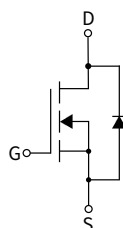
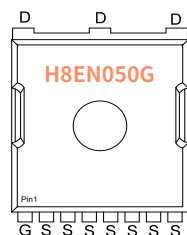
- Applications

- Power switching application
- DC-DC Converter
- Power Management

- **Mechanical Data**

- Case: TOLL
Molding compound meets UL 94V-0 flammability rating, RoHS-compliant,halogen-free
- Terminals: Solder plated, solderable per MIL-STD-750,Method 2026

- **Function Diagram**



● Ordering Information

PACKAGE	PACKAGE CODE	UNIT WEIGHT(g)	REEL(pcs)	BOX(pcs)	CARTON(pcs)	DELIVERY MODE
TOLL	R3	0.753	2000	4000	28000	13"

● **Maximum Ratings** (Ta=25°C Unless otherwise specified)

PARAMETER	SYMBOL	UNIT	VALUE
Drain-source Voltage	V_{DS}	V	85
Gate-source Voltage	V_{GS}	V	± 20
Drain Current	I_D	A	160
Pulsed Drain Current ⁽¹⁾	I_{DM}	A	640
Total Power Dissipation	P_D	W	246
Single pulse avalanche energy ⁽²⁾	EAS	mJ	324
Junction temperature	T_J	°C	-55 ~+150
Storage temperature	T_{stg}	°C	-55 ~+150
Thermal Resistance Junction-to-Case	$R_{\theta JC}$	°C / W	0.51

● Static Parameter Characteristics (Tj=25°C Unless otherwise specified)

PARAMETER	SYMBOL	Condition	UNIT	Min	Typ	Max
Drain-Source Breakdown Voltage	BV_{DSS}	$V_{GS}=0V, I_D=250\mu A$	V	85	—	—
Zero Gate Voltage Drain Current	I_{DSS}	$V_{DS}=85V, V_{GS}=0V$	μA	—	—	1.0
Gate-Body Leakage Current	I_{GSS}	$V_{GS}=\pm 20V, V_{DS}=0V$	nA	—	—	± 100
Gate Threshold Voltage	$V_{GS(th)}$	$V_{DS}=V_{GS}, I_D=250\mu A$	V	2	3	4
Static Drain-Source On-Resistance ⁽³⁾	$R_{DS(ON)}$	$V_{GS}=10V, I_D=50A$	m Ω	—	3.8	4.6

● Dynamic Parameters

PARAMETER	SYMBOL	Condition	UNIT	Min	Typ	Max
Input Capacitance	C_{iss}	$V_{DS}=40V, V_{GS}=0V, f=1MHz$	pF	—	3457	—
Output Capacitance	C_{oss}			—	740	—
Reverse Transfer Capacitance	C_{rss}			—	25	—

● Switching Parameters

PARAMETER	SYMBOL	Condition	UNIT	Min	Typ	Max
Turn-on Delay Time	$t_{D(on)}$	$V_{GS}=10V, V_{DD}=40V, I_D=50A, R_{GEN}=3\Omega$	nS	—	17	—
Turn-on Rise Time	t_r		nS	—	39	—
Turn-off Delay Time	$t_{D(off)}$		nS	—	64	—
Turn-off fall Time	t_f		nS	—	42	—
Total Gate Charge	Q_g	$V_{DS}=40V, I_D=50A, V_{GS}=10V$	nC	—	56	—
Gate-Source Charge	Q_{gs}		nC	—	18.2	—
Gate-Drain Charge	Q_{gd}		nC	—	15	—

● Drian-Source Diode Characteristics

PARAMETER	SYMBOL	Condition	UNIT	Min	Typ	Max
Diode Forward Voltage	V_{SD}	$I_S=160A, V_{GS}=0V$	V	—	—	1.2
Maximum Body-Diode Continuous Current	I_S	—	A	—	—	160
Reverse Recovery Time	T_{rr}	$I_S=160A, di/dt=100A/us, T_J=25^\circ C$	nS	—	45	—
Reverse Recovery Charge	Q_{rr}		nC	—	56	—

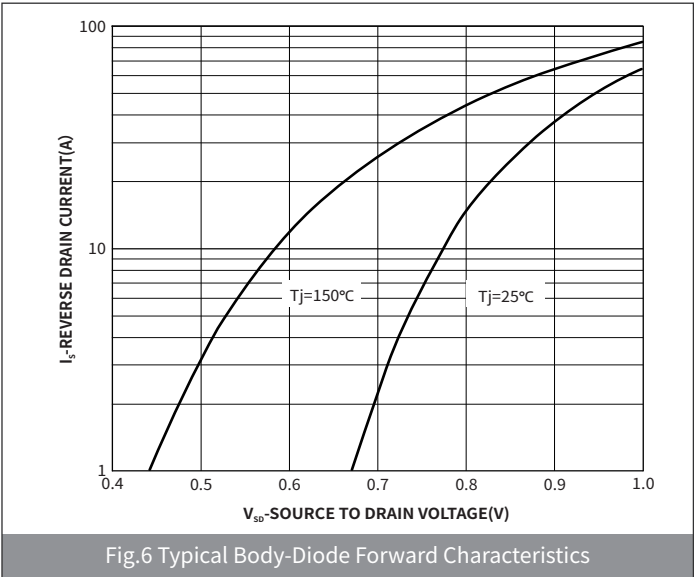
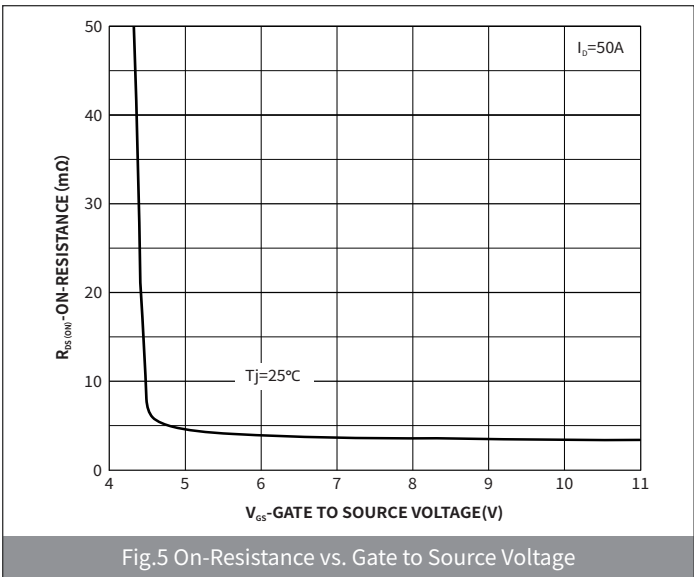
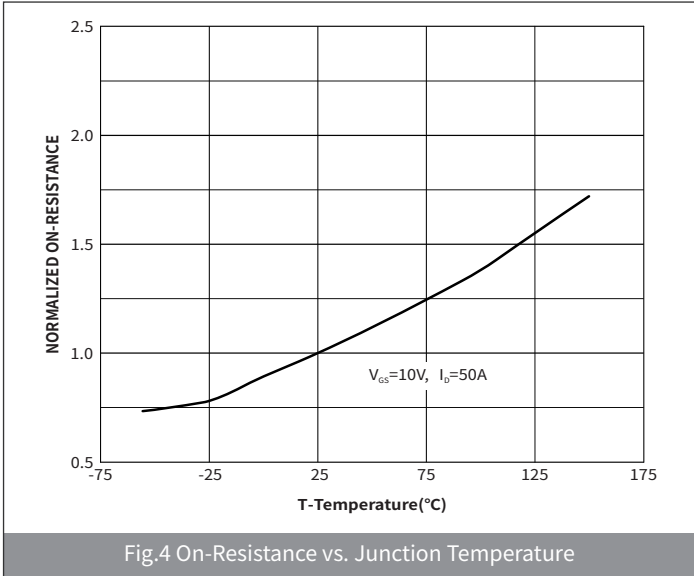
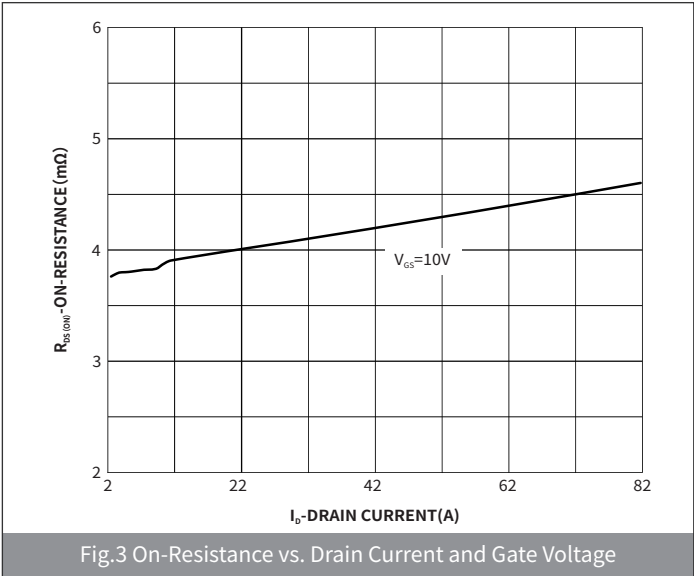
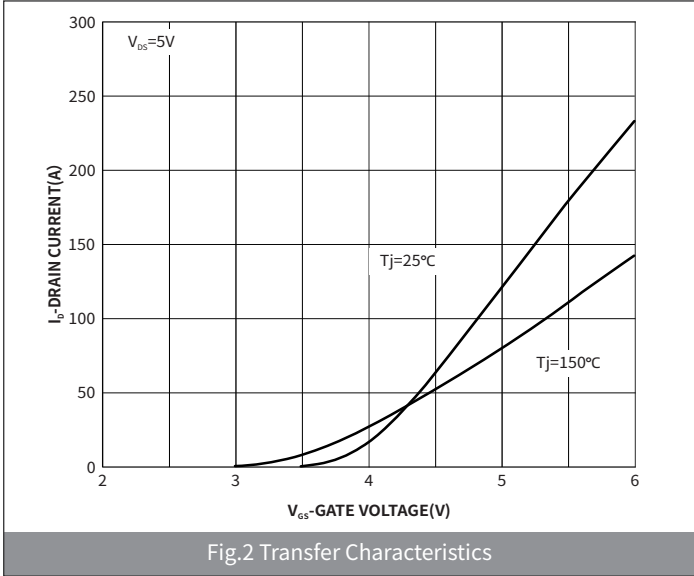
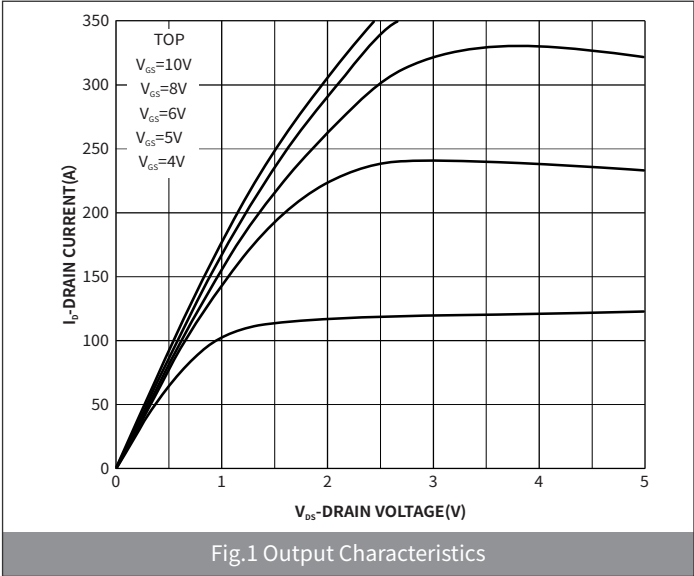
Note :

(1)Repetitive Rating: Pulse width limited by maximum junction temperature.

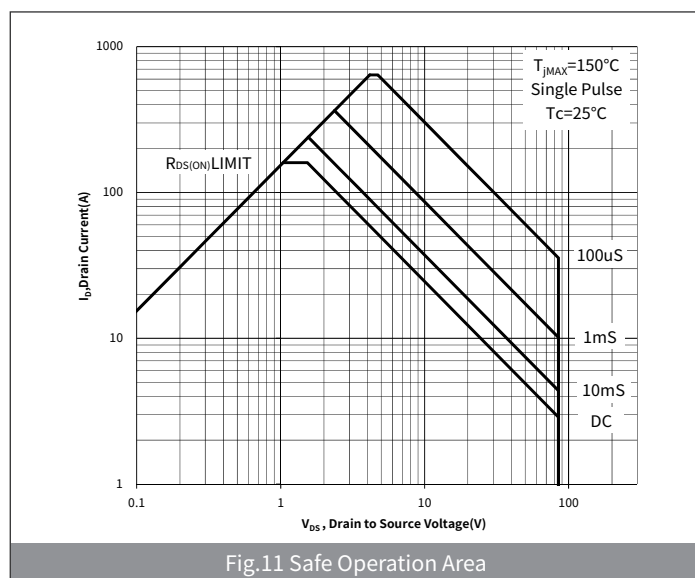
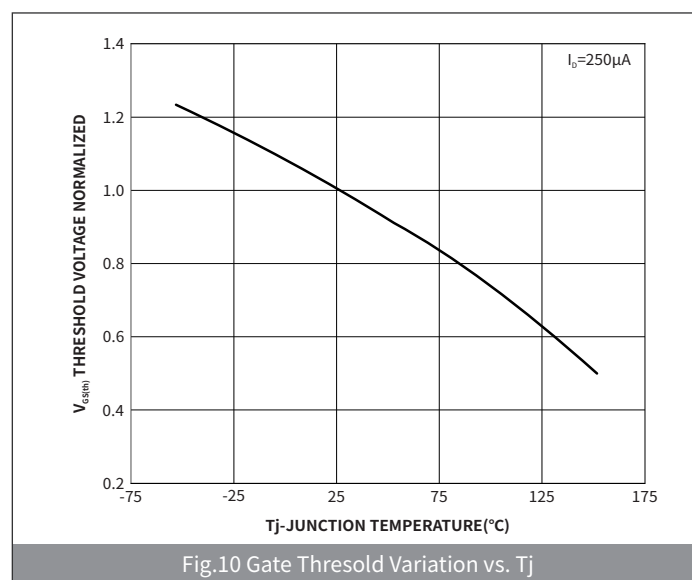
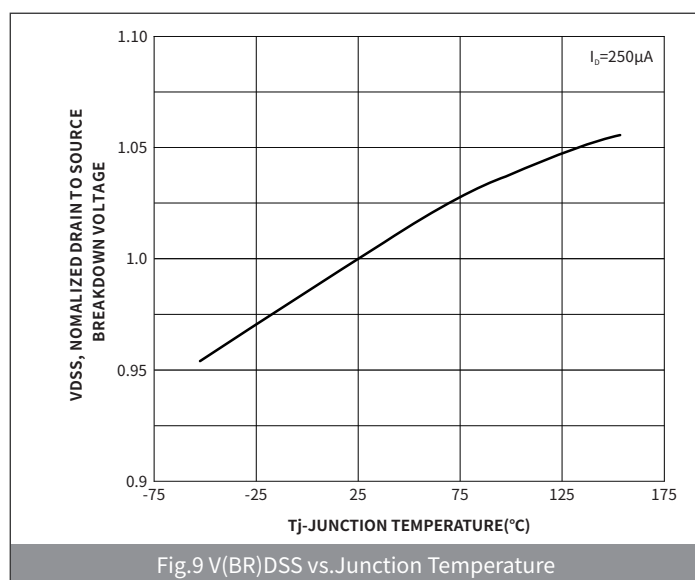
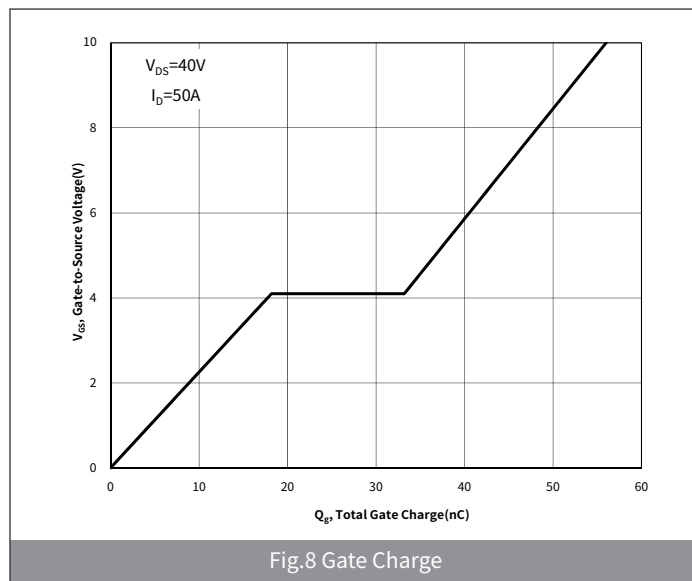
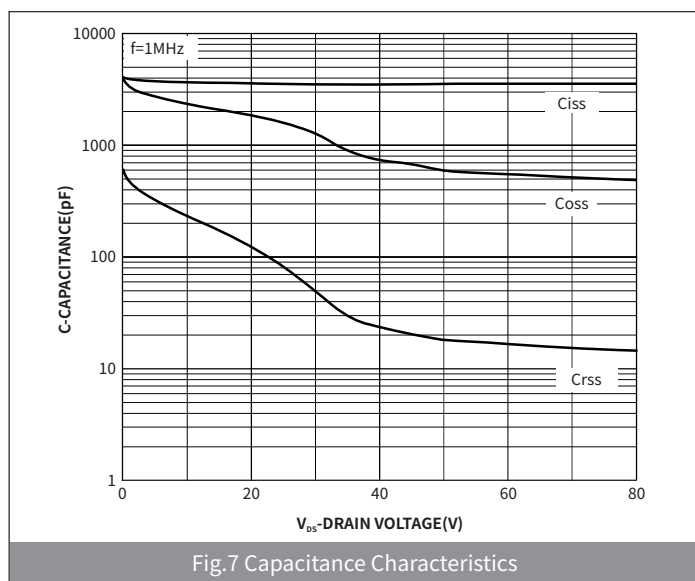
(2)EAS condition : Tj=25°C ,VDD=40V,VG=10V,L=0.5mH,IAS=36A,Rg=25Ω.

(3)Pulse Test: Pulse Width ≤ 300μs, Duty Cycle ≤ 2%.

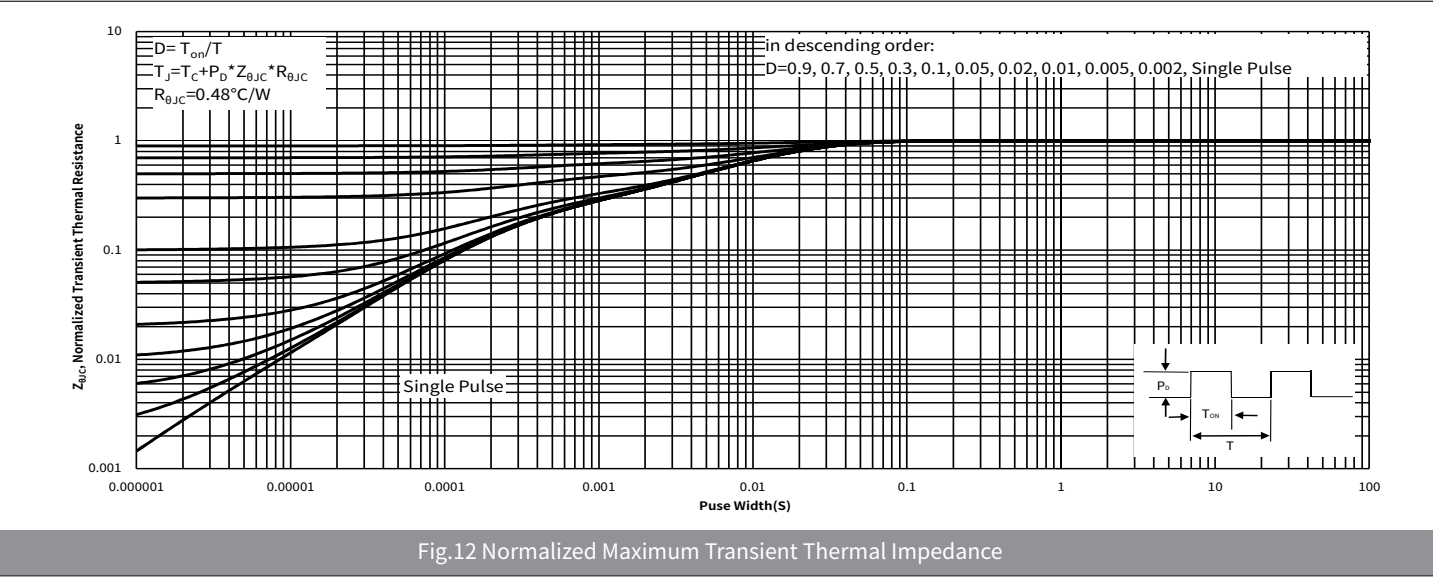
● Ratings And Characteristics Curves (Ta=25°C Unless otherwise specified)



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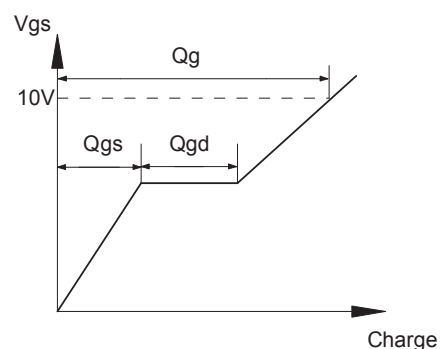
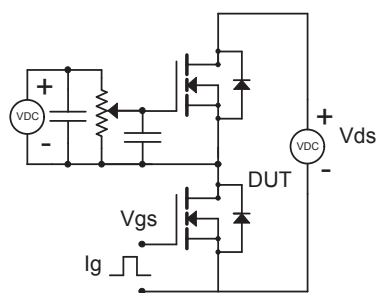
● Package Outline Dimensions (TOLL)

Symbol	Dimensions			
	Millimeters		Inches	
	Min.	Max.	Min.	Max.
A	2.20	2.4	0.087	0.094
b	0.65	0.90	0.026	0.035
b1	9.7	9.90	0.382	0.390
b3	1.15	1.35	0.045	0.053
c	0.40	0.60	0.016	0.024
D	10.28	10.48	0.405	0.413
D2	3.20	3.40	0.126	0.134
D4	4.45	4.65	0.175	0.183
E	9.80	10.00	0.386	0.394
E1	7.90	8.30	0.311	0.327
E2	2.8	3.20	0.110	0.126
e	1.2BSC		1.2BSC	
H	11.48	11.88	0.452	0.468
H1	6.95REF		6.95REF	
j	0.35REF		0.35REF	
K	3.0REF		3.0REF	
L	1.35	1.75	0.053	0.069
L1	0.50	0.90	0.020	0.035
L2	0.50	0.70	0.020	0.028
L3	0.25	0.65	0.010	0.026
Q	8.0REF		8.0REF	
θ	10° REF		10° REF	

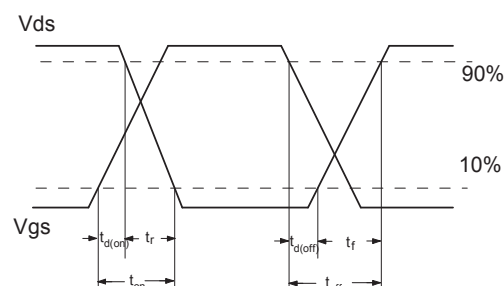
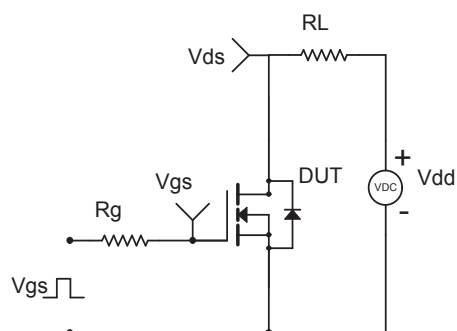
● Suggested Pad Layout

Symbol	Dimensions			
	Millimeters		Inches	
	Min.	Max.	Min.	Max.
A	9.95	10.2	0.392	0.402
A1	2.60	2.80	0.102	0.110
B	8.2	8.3	0.323	0.327
b	0.6	0.8	0.024	0.031
C	0.9	1.1	0.035	0.043
c	0.6	0.8	0.024	0.031
D	6.7	6.9	0.264	0.272
D1	13.1	13.3	0.516	0.524
e	1.0	1.2	0.039	0.047
e1	0.2	0.4	0.008	0.016

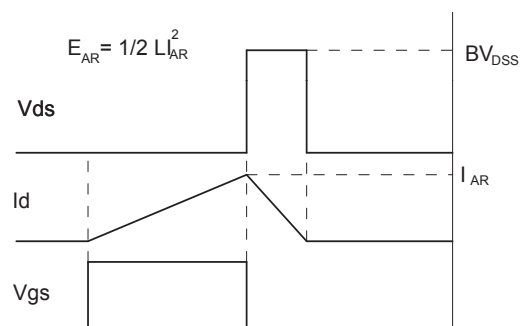
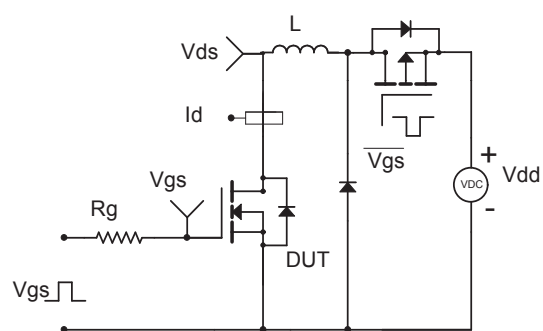
1. Gate Charge Test Circuit & Waveforms



2. Resistive Switching Test Circuit & Waveforms



3. Unclamped Inductive Switching (UIS) Test Circuit & Waveforms



4. Diode Recovery Test Circuit & Waveforms

